Notice of References Cited Application/Control No. 10/047,914 Examiner John Rivell U.S. PATENT DOCUMENTS Applicant(s)/Patent Under Reexamination TANAKA ET AL. Art Unit 3753 Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-6,005,772	12-1999	Terao et al.	165/104.33
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